Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/685,002	KIM ET AL.
Examiner	**Art Unit**
Dennis Rosario	2624

SEARCHED

Class	Subclass	Date	Examiner
382	118, 190	1129/07	DR
	191, 195		
	201, 205		
	206, 225		
	115 (118)	6/29/07	DR
		(2/11/08)	(DR)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See PG Pub		1/26/07	DR
Printout		(2/11/08)	(DR)

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
(updated)		
(East, all dB)	1129/07	DR
	(6/29/07)	(DR)
	(2/11/08)	(DR)
(Inventor)	1/26/07	DR
	(6/29/07)	(DR)
	(2/11/08)	(DR)
PG Pub Printout	1/26/07	DR
	(2/11/08)	(DR)
IEEE - Feature (near) vector and Fourier	1/26/07	DR
and image - IEEE - feature (near) vector	6/29/07	DR
and face and nose - ACM + Fourier + vector + feature	6/29/07	DR
+ mouth + face - IEEE - Fourier (near/4) vector and (face or facial) -	2/11/08	DR